

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination	
	10/009,704	WALKER ET AL.	
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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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V	Devyatikh et al. "Vibrational spectra of liquid high-purity silicon, germanium, sulfur, and selenium hydrides and their solutions in liquid krypton" Vysokochistye Veshchestva (1988), (6), 21-8
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X	Kondaurov et al. "Vibrational spectra of phosphine of various degrees of purity in a solution of liquid argon" Vysokochistye Veshchestva (1993), (3), 119-26

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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